**LS7030** 



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# **8 DECADE MULTIPLEXED COUNTER**

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# **FEATURES:**

- DC to 7.5 MHz Count Frequency
- Multiplexed BCD and 7 Segment Outputs
- DC to 500 kHz Scan Frequency
- +4.75V to +15V Operation (Vss Vdd)
- Compatible with CMOS Logic
- High Input Noise Immunity
- Counter Output Latches
- Leading Zero Blanking
- Low Power Dissipation
- · All inputs protected
- 40 Pin DIP See Figure 1

# **DESCRIPTION:** (See Block Diagram, Figure 4.)

The LS7030 is a MOS, 8 decade up counter. The circuit includes latches, multiplexer, leading zero blanking and 7 segment data outputs.

#### **8 DECADE UP COUNTER**

The eight decade ripple through counter increments on the negative edge of the input count pulse. Maximum ripple time is 12µs (9999999 to 00000000). Maximum count frequency is 7.5MHz.

All decades are reset to zero when Reset input is brought low for a minimum of 4µs. The Overflow flip-flop is reset at the same time. Reset must be high for a minimum of 1µs before next valid count can be recorded.

# **LATCHES**

Contents of counter are transferred to latches when LOAD signal is brought low for a minimum of 4µs and kept low until a minimum of 12µs has elapsed from previous negative edge of count pulse (ripple time). Storage of valid data occurs when LOAD signal is high for a minimum of 1µs before next negative edge of count pulse or reset. Data is transferred for Overflow flip-flop to Overflow latch at the same time.

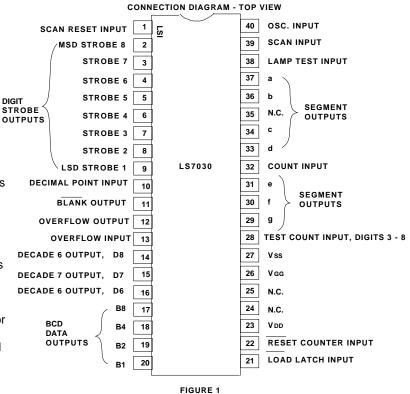
# **SCAN OSCILLATOR AND COUNTER**

The scan counter is driven by an internal oscillator whose frequency is determined by a capacitor connected between Oscillator input and Scan input. An external scan clock applied to Scan input can also drive the scan counter. Scan counter advances on negative edge of scan clock.

The counter scans from MSD to LSD. When Scan Reset input is brought high the scan counter is forced to MSD state. Internal synchonization guarantees proper scanning no matter when Scan Reset is brought low relative to scan clock. Maximum scan frequency is 500kHz.

### **DECIMAL POINT**

A high at the Decimal Point input resets the Blanking flip-flop causing the display to unblank. Decimal Point should be brought high at start of digit time which has active Decimal Point.



### **DIGIT STROBES**

Timing of Digit Strobes is arranged such that both edges of strobe are guardbanded by a minimum 400ns within valid BCD data when scan frequency is 100kHz or less. The guardband is a minimum of 200ns at 250kHz scan frequency. At 500kHz only negative edge of Strobe is guaranteed to be within valid BCD data by a minimum 200ns.

#### **OVERFLOW**

The Overflow flip-flop sets on the first negative transition of the Overflow Input and remains set until Reset is brought low. Data is transferred from Overflow flip-flop to Overflow Latch when Load is brought low. A high at the Overflow Latch causes display to unblank. Overflow Output is output of Overflow Latch. MSB outputs of Decades 6, 7, 8 are available for use as Overflow Input.

#### **BLANKING**

Leading zero blanking is employed. At start of each MSD to LSD scan, display is blanked until a nonzero digit or active decimal point is encountered. Displaly unblanks during LSD time and for a whole scan when Overflow output is high. When Scan Reset is applied, display blanks to prevent display damage.

Blanking information is available at Blank output and is incorporated into 7 segment information.

#### **BCD and 7 SEGMENT DATA**

Data is available in BCD and 7 segment format. BCD data can be demultiplexed using Digit Strobes as latch enable signals.

# **POWER SUPPLIES**

+4.75 Volts to +15 Volts single power supply operation is obtained when Vgg and Vdd are tied together. Inputs and outputs are CMOS compatible and Minimum Input Noise Immunity of 25% of power supply is guaranteed except for Test Count Input. (Inputs are TTL compatible at +4.75V to +5.25V operation.)

With Vgg at -12V, Vdd at OV and Vss at +5V, all inputs are TTL and CMOS compatible. All outputs are CMOS compatible and BCD and BLANK outputs also provide standard TTL compatibility. In addition, Overflow Output is low power TTL compatible. In either mode outputs swing between Vdd and Vss.

# **MAXIMUM RATINGS**

PARAMETER	SYMBOL	VALUE	UNITS
Storage Temperature	Tstg	-65 to +150	°C
Operating Temperature	TA	-25 to +70	°C
Voltage (any pin to Vss)	Vmax	-30 to +0.5	V

#### DC ELECTRICAL CHARACTERISTICS

(VDD = VGG = OV, Vss = +4.75 to +15V, -25°C TA +70°C unless otherwise specified.)

	PARAMETER Operating Supply Current (fc = 7.5MHz)	SYMBOL Idds	MIN -	<b>MAX</b> 15	<b>UNITS</b> mA
	Input Noise Immunity Low and High	Vni	25% (Vss - VDD)	-	V
	Test Count Input	Vil Vih	Vss - 20 Vss - 1.0	Vss - 3.95 Vss	V V
D6, D7, D8 OF, BCD Blank	Output Voltage "0" Output Voltage "1"	Vol Voh	- Vss - 1.0	+0.2	V V
(See Note 1)	Output Voltage "0" (sinking 10μΑ) Output Voltage "1"	Vol	-	+0.5	V
Segment and Strobe Outputs (See Note 2)	Vss = 4.75 (Voh = Vss - 0.5V) (Voh = Vss - 1V) (Voh = Vss - 4V) Vss = 10V (Voh = Vss - 2V) (Voh = Vss - 3V) Vss = 15V (Voh = Vss - 2V) (Voh = Vss - 3V)	- - - - -	0.05 0.25 0.90 2.0 3.0 3.0 4.5	- - - - -	mA mA mA mA mA mA

NOTE 1: Current Sink = Same as segment and strobe outputs. Current Source = N/A at Voh = Vss - 0.5V for Vss = +4.75V

 $35\mu A$  at Voh = Vss - 1V for Vss = +4.75V

40% of segment and strobe outputs at all other specified operating points.

NOTE 2: Limit segment current to 4.5mA maximum. Limit strobe current to 6mA maximum.

The following inputs have internal pull down resistors to VDD with maximum sink current of  $5\mu A$  at Vss input.

Scan Reset Test Count Count
Decimal Point Overflow Lamp Test

# **SCAN OSCILLATOR**

CAPACITANCE	TYPICAL OSCILLATOR FREQUENCY			
	4.75V	10V	15V	
50pF	40.0 kHz	24.2kHz	22.2 kHz	
100pF	22.2 kHz	14.8kHz	13.8 kHz	
470pF	5.0 kHz	3.6kHz	3.5 kHz	
750pF	3.3 kHz	2.4kHz	2.2 kHz	
2000pF	1.3 kHz	0.91kHz	0.85 kHz	

# **ELECTRICAL CHARACTERISTICS:**

 $(VDD = VGG = OV, Vss = +4.75 \text{ to } +15V, -25^{\circ}C$  TA  $+70^{\circ}C$  unless otherwise specified.)

PARAMETER	SYMBOL	MIN	MAX	UNITS
Count test and Count frequency				
$(Vss = +5V \pm 5\%)$	fc, ftc	DC	7.5	MHz
(Vss = +10V)	fc, ftc	DC	6	MHz
(Vss = +15V)	fc, ftc	DC	5	MHz
Scan frequency	fsc	DC	500	kHz
Count Pulse Width				
$(Vss = +5V \pm 5\%)$	tcpw	66	-	ns
(Vss = +10V)	tcpw	83	-	ns
(Vss = +15V)	tcpw	100	-	ns
Count Ripple Time	tcr	-	12	μs
Load Pulse Width	tlpw	4	-	μs
Load Removal Tme	tır	-	1	μs
Reset Pulse Width	trpw	4	-	μs
Reset Removal Time	trr	-	1	μs
Rise and fall time				
Count Pulse	trfc	-	4	μs
Reset Pulse	trfr	-	4	μs
test Count Pulse	trftc	-	80	μs
*Strobe Guard Band time (fsc 100kHz)	tgb	400	-	ns
*Strobe Guard Band time (100kHz fsc 250kHz)	<b>t</b> gb	200	-	ns
*Strobe Guard Band time (250kHz fsc 500kHz) negative edge only	tgb	200	-	ns

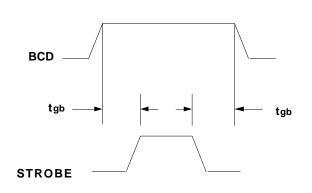


FIGURE 2. GUARD BANDED STROBE

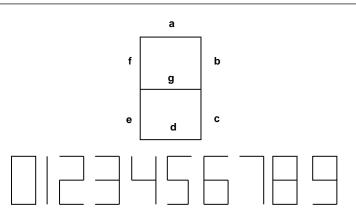


FIGURE 3. SEVEN SEGMENT FONT

# TTL COMPATIBLE OUTPUTS:

**POWER SUPPLIES:** Vss =  $+5V \pm 5\%$ , VDD = 0V, VGG =  $-12V \pm 5\%$ 

OUTPUT LEVELS: "1" Level Vss - 0.5V (sourcing 100 $\mu$ A)  $\overline{\text{BLANK}}$  AND BCD 0.4V (sinking 1.6mA)  $\overline{\text{BLANK}}$  DATA OUTPUTS

"1" Level Vss - 0.5V (sourcing 40 $\mu$ A) OVERFLOW "0" Level 0.4V (sinking 0.18mA)

All other outputs as specified for single power supply, Vss =  $\pm$  15V, operation. Inputs as specified for single power supply, Vss =  $\pm$ 5% operation.

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